Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/672,781	EHRKE ET AL.
Examiner	**Art Unit**
Albert K. Wong	2612

SEARCHED			
Class	Subclass	Date	Examiner
340	870.02 870.03	6/9/06	h
375	219	"	"
370	346	"	"

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
meter concentrator MIU network channel address	6/9/06	h